



16-Channel/Dual 8-Channel High Performance CMOS Analog Multiplexers

General Description

The DG406/DG407 are monolithic CMOS analog multiplexers (muxes). The DG406 is a single-ended 1-of-16 device, and the DG407 is a differential 2-of-8 device. Both are pin and functionally compatible with the industry-standard DG506A/DG507A.

The DG406/DG407 are fabricated with Maxim's new improved silicon gate process. Both parts offer low on resistance (100Ω max), improved leakage over temperature, low power consumption ($I_{SUPPLY} = 75\mu A$ max) and fast switching speeds ($t_{TRANS} = 250ns$ max). The 44V maximum breakdown voltage allows switch-off blocking capability rail-to-rail.

These muxes can be used with a single positive supply (+12V to +30V) or split supplies ($\pm 4.5\text{V}$ to $\pm 20\text{V}$) while retaining CMOS logic input compatibility. CMOS inputs provide reduced input loading.

Applications

Sample-and-Hold Circuits

Test Equipment

Winchester Disk Drives

Heads-Up Displays

Guidance and Control Systems

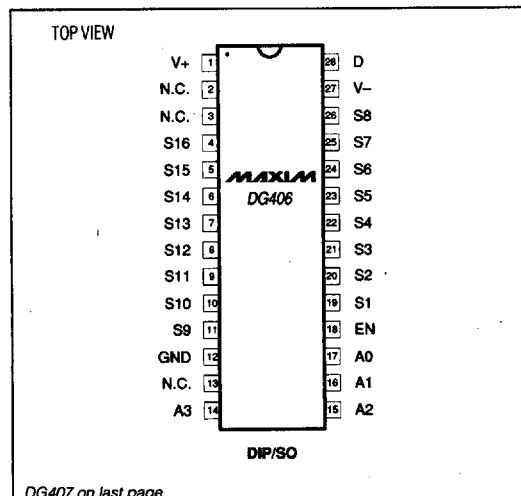
Military Radios

Communications Systems

Battery-Operated Systems

PBX, PABX

Pin Configurations



Features

- ◆ $r_{DS(ON)}$: 100 Ω Max, $\Delta r_{DS(ON)}$: 15 Ω Max $T_{51}(-)$
- ◆ t_{TRANS} : 250ns Max
- ◆ Leakage - $T_A = T_{MIN}$ to T_{MAX}
- ◆ $I_{S(OFF)}$: 50nA Max
- ◆ $I_{D(OFF)}$: 100nA Max (DG407), 200nA Max (DG406)
- ◆ $I_{(ON)}$: 100nA Max (DG407), 200nA Max (DG406)
- ◆ Q : 20pC Typ
- ◆ I_{SUPPLY} : 75 μ A Max
- ◆ Single- or Bipolar-Supply Operation
- ◆ TTL/CMOS Logic Compatible

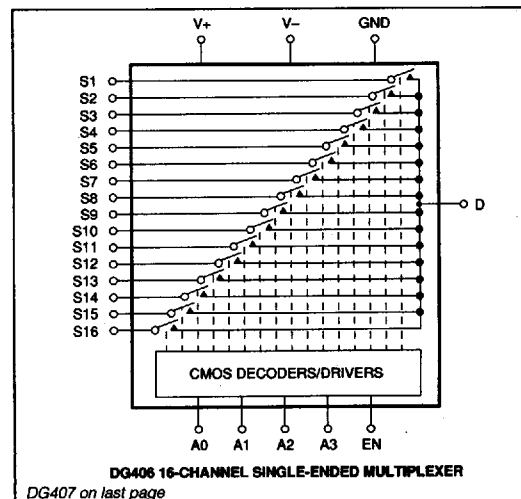
Ordering Information

PART	TEMP. RANGE	PIN-PACKAGE
DG406C/D	0°C to +70°C	Dice*
DG406DJ	-40°C to +85°C	28 Plastic DIP
DG406DN	-40°C to +85°C	28 PLCC
DG406DK	-40°C to +85°C	28 CERDIP
DG406AK	-55°C to +125°C	28 CERDIP**
DG407C/D	0°C to +70°C	Dice*
DG407DJ	-40°C to +85°C	28 Plastic DIP
DG407DN	-40°C to +85°C	28 PLCC
DG407DK	-40°C to +85°C	28 CERDIP
DG407AK	-55°C to +125°C	28 CERDIP**

* Contact factory for dice specifications.

**** Contact factory for availability and processing to MIL-STD-883.**

Functional Diagrams



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ABSOLUTE MAXIMUM RATINGS

Voltage Referenced to V-

V+	44V
GND	25V
Digital Inputs V_S , V_D (Note 1)	V- -2V to V+ +2V or 30mA (whichever occurs first)
Current (any terminal, except S or D)	30mA
Continuous Current, S or D	20mA
Peak Current, S or D (pulsed at 1ms, 10% duty cycle max)	40mA

Continuous Power Dissipation ($T_A = +70^\circ\text{C}$) (Note 2)

28-Pin Plastic DIP (derate 9.09mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$)	727mW
28-Pin PLCC (derate 10.53mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$)	842mW
28-Pin CERDIP (derate 16.67mW/ $^\circ\text{C}$ above $+70^\circ\text{C}$)	1333mW
Operating Temperature Ranges:	
DG406/407C/D	0°C to $+70^\circ\text{C}$
DG406/407D	-40°C to $+85^\circ\text{C}$
DG406/407AK	-55°C to $+125^\circ\text{C}$
Storage Temperature Range	-65°C to $+150^\circ\text{C}$
Lead Temperature (soldering, 10 sec)	$+300^\circ\text{C}$

Note 1: Signals on S_x , D_x , or IN_x exceeding V_+ or V_- are clamped by internal diodes. Limit forward current to maximum current ratings.

Note 2: All leads are soldered or welded to PC board.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS (Dual Supplies)

($V_+ = 15\text{V}$, $V_- = -15\text{V}$, $\text{GND} = 0\text{V}$, $V_{AH} = +2.4\text{V}$, $V_{AL} = +0.8\text{V}$, $T_A = T_{\text{MIN}}$ to T_{MAX} , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS			MIN	TYP (Note 3)	MAX	UNITS
SWITCH								
Analog Signal Range	V _{ANALOG}	(Note 4)			-15		15	V
Drain-Source On Resistance	r _{DS(ON)}	I _S = -10mA, V _D = ±10V		T _A = +25°C		50	100	Ω
				T _A = T _{MIN} to T _{MAX}			125	
r _{DS(ON)} Matching Between Channels	Δr _{DS(ON)}	V _D = ±10V (Note 5)		T _A = +25°C			15	Ω
Source-Off Leakage Current	I _{S(OFF)}	V _D = ±10V, V _S = ∓10V, V _{EN} = 0V		T _A = +25°C	-0.5		0.5	nA
				T _A = T _{MIN} to T _{MAX}	-50		50	
Drain-Off Leakage Current	I _{D(OFF)}	V _S = ±10V, V _D = ∓10V, V _{EN} = 0V	DG406	T _A = +25°C	-2		2	nA
				T _A = T _{MIN} to T _{MAX}	-200		200	
			DG407	T _A = +25°C	-2		2	nA
				T _A = T _{MIN} to T _{MAX}	-100		100	
Drain-On Leakage Current	I _{D(ON)} + I _{S(ON)}	V _D = ±10V, V _S = ±10V, sequence each switch on	DG406	T _A = +25°C	-2		2	nA
				T _A = T _{MIN} to T _{MAX}	-200		200	
			DG407	T _A = +25°C	-2		2	nA
				T _A = T _{MIN} to T _{MAX}	-100		100	

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ELECTRICAL CHARACTERISTICS (continued)

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(V+ = 15V, V- = -15V, GND = 0V, V_{AH} = +2.4V, V_{AL} = +0.8V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS			MIN	TYP (Note 3)	MAX	UNITS
INPUT								
Input Current with Input Voltage High	I _{AH}	V _A = 2.4V, 15V			-10		10	μA
Input Current with Input Voltage Low	I _{AL}	V _{EN} = 0V, 2.4V, V _A = 0V			-10		10	μA
SUPPLY								
Power-Supply Range					±4.5		±20	V
Positive Supply Current	I+	V _{EN} = V _A = 0V					75	μA
Negative Supply Current	I-	V _{EN} = V _A = 0V			-75			μA
Positive Supply Current	I+	V _{EN} = 2.4V, V _A = 0V		T _A = +25°C T _A = T _{MIN} to T _{MAX}			0.5 2	mA
Negative Supply Current	I-	V _{EN} = 2.4V, V _A = 0V			-500			μA
DYNAMIC								
Transition Time	t _{TRANS}	Figure 1		T _A = +25°C			250	ns
Break-Before-Make Interval	t _{OPEN}	Figure 2		T _A = +25°C	10			ns
Enable Turn-On Time	t _{ON(EN)}	Figure 3		T _A = +25°C			200	ns
Enable Turn-Off Time	t _{OFF(EN)}	Figure 3		T _A = +25°C			150	ns
Charge Injection	Q	C _L = 1nF, V _S = 0V, R _S = 0Ω		T _A = +25°C		20		pC
Off Isolation (Note 6)		V _{EN} = 0V, R _L = 1kΩ, f = 100kHz		T _A = +25°C		-65		dB
Logic Input Capacitance	C _{IN}	f = 1MHz		T _A = +25°C		8		pF
Source-Off Capacitance	C _{S(OFF)}	f = 1MHz, V _{EN} = V _S = 0V		T _A = +25°C		11		pF
Drain-Off Capacitance	C _{D(OFF)}	f = 1MHz, V _{EN} = V _D = 0V	DG406 DG407	T _A = +25°C		70 35		pF
Channel-On Capacitance	C _{D(ON)} + C _{S(ON)}	f = 1MHz, V _{EN} = V _D = 0V	DG406 DG407	T _A = +25°C		100 50		pF

DG406/DG407

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ELECTRICAL CHARACTERISTICS (Single Supply)

($V_+ = 12V$, $V_- = 0V$, $GND = 0V$, $V_{AH} = +2.4V$, $V_{AL} = +0.8V$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
SWITCH						
Analog Signal Range	V_{ANALOG}	(Note 4)				V
Drain-Source On Resistance	$r_{DS(ON)}$	$I_S = -1mA$, $V_D = 3V, 10V$		90		Ω
DYNAMIC						
Transition Time	t_{TRANS}	Figure 1, $V_{S1} = 8V$, $V_{S8} = 0V$, $V_{IN} = 2.4V$		300		ns
Enable Turn-On Time	$t_{ON(EN)}$	Figure 3, $V_{INH} = 2.4V$, $V_{INL} = 0V$, $V_{S1} = 5V$		250		ns
Enable Turn-Off Time	$t_{OFF(EN)}$	Figure 3, $V_{INH} = 2.4V$, $V_{INL} = 0V$, $V_{S1} = 5V$		150		ns
Charge Injection	Q	$C_L = 1nF$, $V_S = 6V$, $R_S = 0\Omega$		5		pC

Note 3: The algebraic convention, where the most negative value is a minimum and the most positive value a maximum, is used in this data sheet.

Note 4: Guaranteed by design.

Note 5: $\Delta r_{DS(ON)} = \Delta r_{DS(ON)} MAX - \Delta r_{DS(ON)} MIN$

Note 6: Worst-case isolation is on channel 4 because of its proximity to the drain pin. Off isolation = $20 \log_{10} V_O/V_S$, V_O = output, V_S = input to off switch.

Truth Tables

A3	A2	A1	A0	EN	ON Switch
X	X	X	X	0	None
0	0	0	0	1	1
0	0	0	1	1	2
0	0	1	0	1	3
0	0	1	1	1	4
0	1	0	0	1	5
0	1	0	1	1	6
0	1	1	0	1	7
0	1	1	1	1	8
1	0	0	0	1	9
1	0	0	1	1	10
1	0	1	0	1	11
1	0	1	1	1	12
1	1	0	0	1	13
1	1	0	1	1	14
1	1	1	0	1	15
1	1	1	1	1	16

DG406

A2	A1	A0	EN	ON Switch
X	X	X	0	None
0	0	0	1	1
0	0	1	1	2
0	1	0	1	3
0	1	1	1	4
1	0	0	1	5
1	0	1	1	6
1	1	0	1	7
1	1	1	1	8

DG407

LOGIC "0" $V_{AL} \leq 0.8V$, LOGIC "1" $= V_{AH} \geq 2.4V$

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Test Circuits/Timing Diagrams

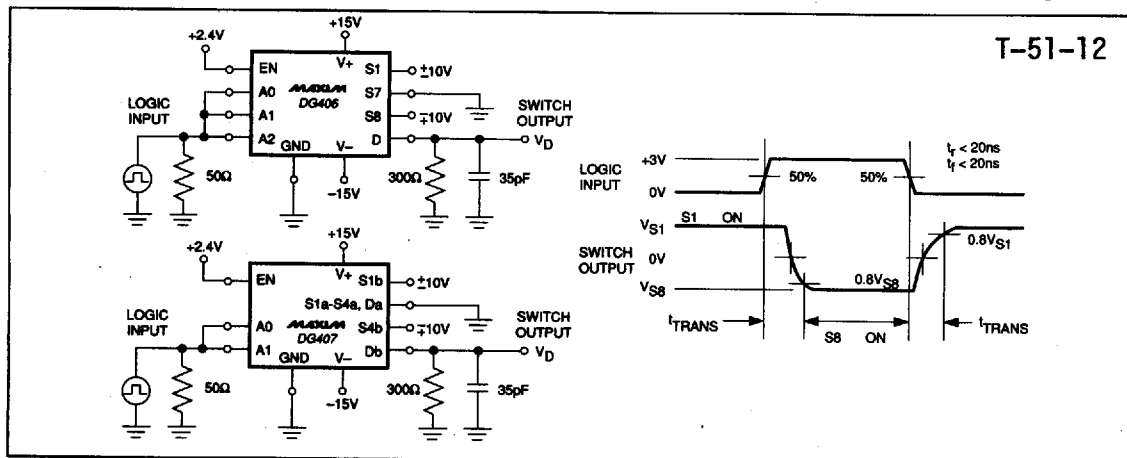


Figure 1. Transition-Time Test Circuit

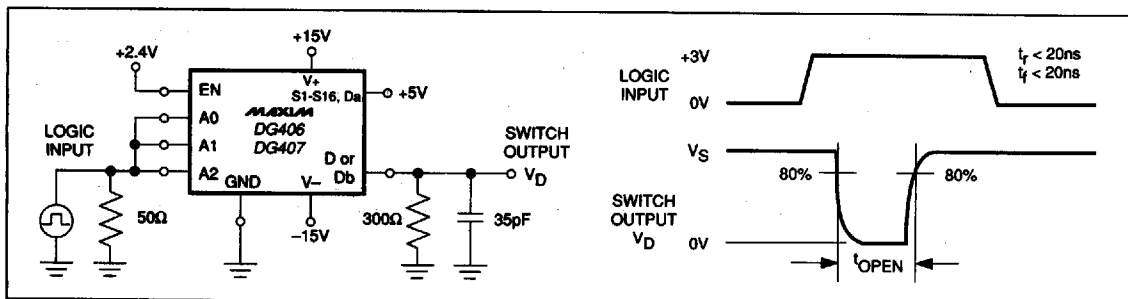


Figure 2. Break-Before-Make Interval Test Circuit

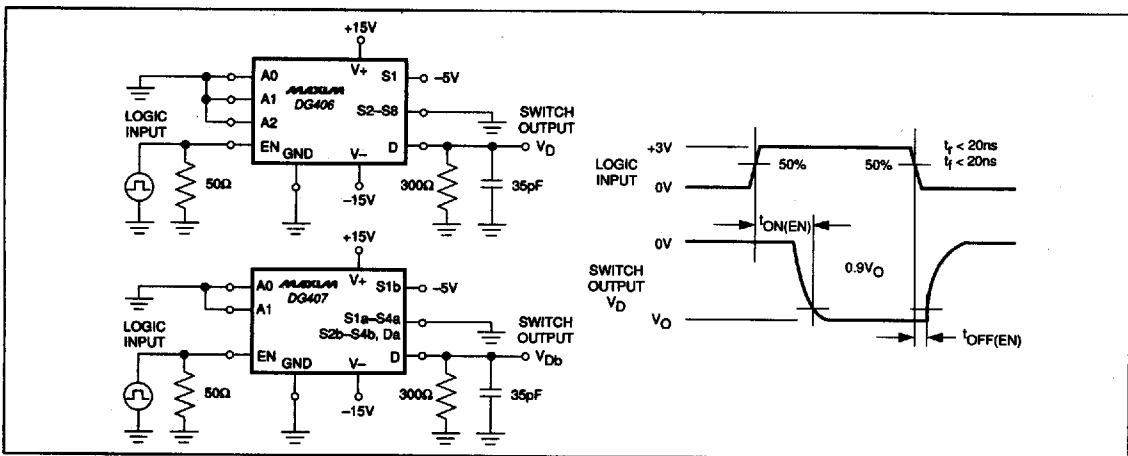


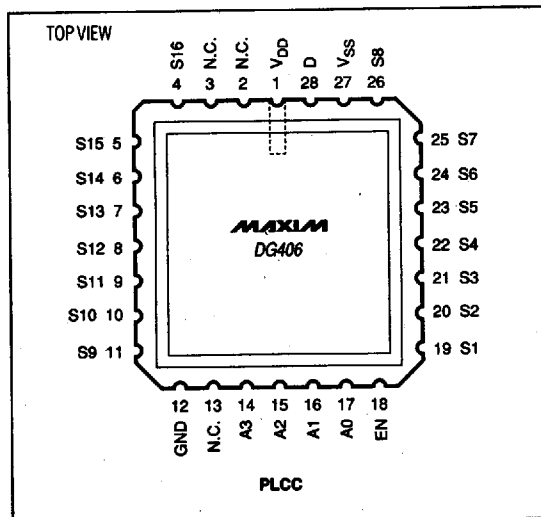
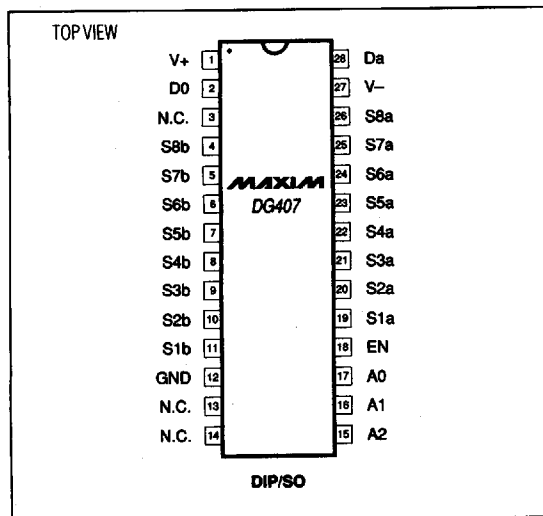
Figure 3. $t_{ON(EN)}$ $t_{OFF(EN)}$ Test Circuit

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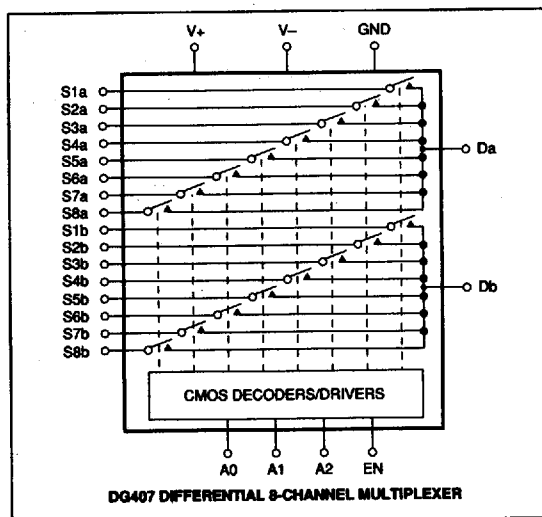
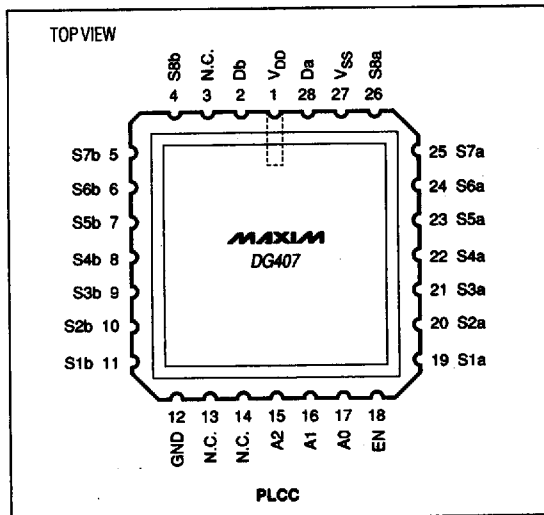
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Pin Configurations (continued)

DG406/DG407



Functional Diagrams (continued)



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